

<b>Notice of References Cited</b>	Application/Control No. 10/803,021		Applicant(s)/Patent Under Reexamination BEAN ET AL.	
	Examiner Charles E. Phillips		Art Unit 3751	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0097669	05-2005	Tobin et al.	004/622
*	B	US-6,805,678	10-2004	Cafaro, Michael	601/16
*	C	US-4,420,846	12-1983	Bonner, Jack D.	4/541.4
*	D	US-5,010,605	04-1991	Shiina et al.	4/541.2
*	E	US-5,657,496	08-1997	Corb et al.	4/541.6
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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